

## Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

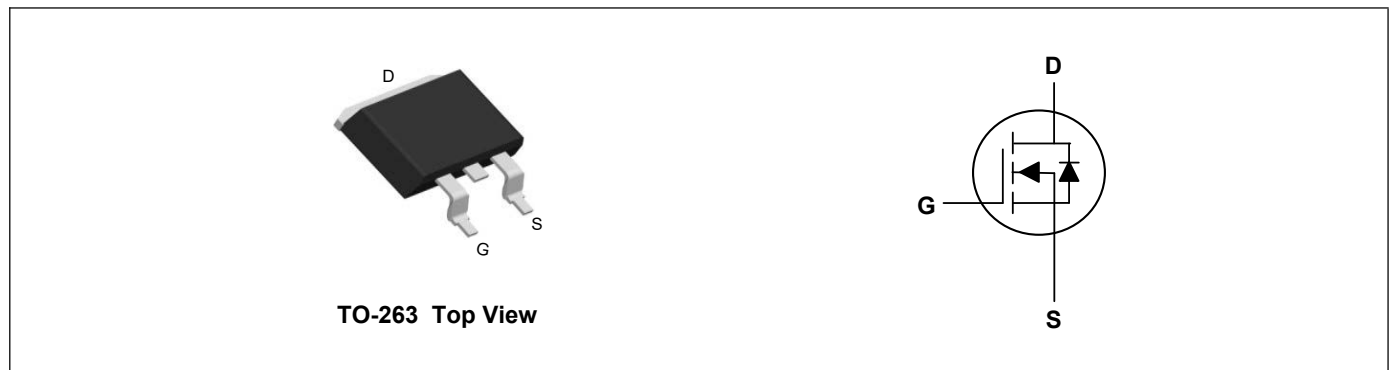
## Applications

- High Frequency Point-of-Load Synchronous Buck Converter
- Networking DC-DC Power System
- Power Tool Application

## Product Summary



$V_{DS}$	100	V
$I_D$	58	A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	22	m $\Omega$



## Absolute Maximum Ratings( $T_C=25^\circ C$ , unless otherwise noted)

Parameter	Symbol	Rating	Units
Drain-Source Voltage	$V_{DS}$	100	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current, $V_{GS}$ @ 10V <sup>1</sup>	$I_D@T_C=25^\circ C$	58	A
Continuous Drain Current, $V_{GS}$ @ 10V <sup>1</sup>	$I_D@T_C=100^\circ C$	37	A
Continuous Drain Current, $V_{GS}$ @ 10V <sup>1</sup>	$I_D@T_A=25^\circ C$	6.8	A
Continuous Drain Current, $V_{GS}$ @ 10V <sup>1</sup>	$I_D@T_A=70^\circ C$	5.4	A
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	130	A
Single Pulse Avalanche Energy <sup>3</sup>	EAS	84	mJ
Avalanche Current	$I_{AS}$	41	A
Total Power Dissipation <sup>4</sup>	$P_D@T_C=25^\circ C$	149	W
Total Power Dissipation <sup>4</sup>	$P_D@T_A=25^\circ C$	2	W
Storage Temperature Range	$T_{STG}$	-55 to 150	$^\circ C$
Operating Junction Temperature Range	$T_J$	-55 to 150	$^\circ C$

## Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance Junction-Ambient <sup>1</sup>	$R_{\theta JA}$	---	62	$^\circ C/W$
Thermal Resistance Junction-Case <sup>1</sup>	$R_{\theta JC}$	---	0.84	$^\circ C/W$

**Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	100	---	---	V
BV <sub>DSS</sub> Temperature Coefficient	ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Reference to 25°C, I <sub>D</sub> =1mA	---	0.096	---	V/°C
Static Drain-Source On-Resistance <sup>2</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =30A	---	18	22	mΩ
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	2.5	---	4.5	V
V <sub>GS(th)</sub> Temperature Coefficient	ΔV <sub>GS(th)</sub>		---	-7	---	mV/°C
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =80V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	---	---	1	uA
		V <sub>DS</sub> =80V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C	---	---	5	
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	---	---	±100	nA
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> =5V, I <sub>D</sub> =30A	---	31	---	S
Gate Resistance	R <sub>g</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f=1MHz	---	1.9	---	Ω
Total Gate Charge (10V)	Q <sub>g</sub>	V <sub>DS</sub> =80V, V <sub>GS</sub> =10V, I <sub>D</sub> =30A	---	27.6	---	nC
Gate-Source Charge	Q <sub>gs</sub>		---	11.4	---	
Gate-Drain Charge	Q <sub>gd</sub>		---	7.9	---	
Turn-On Delay Time	T <sub>d(on)</sub>	V <sub>DD</sub> =50V, V <sub>GS</sub> =10V, R <sub>G</sub> =3.3Ω, I <sub>D</sub> =30A	---	16.5	---	ns
Rise Time	T <sub>r</sub>		---	35	---	
Turn-Off Delay Time	T <sub>d(off)</sub>		---	17.5	---	
Fall Time	T <sub>f</sub>		---	12	---	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz	---	1890	---	pF
Output Capacitance	C <sub>oss</sub>		---	268	---	
Reverse Transfer Capacitance	C <sub>rss</sub>		---	67	---	

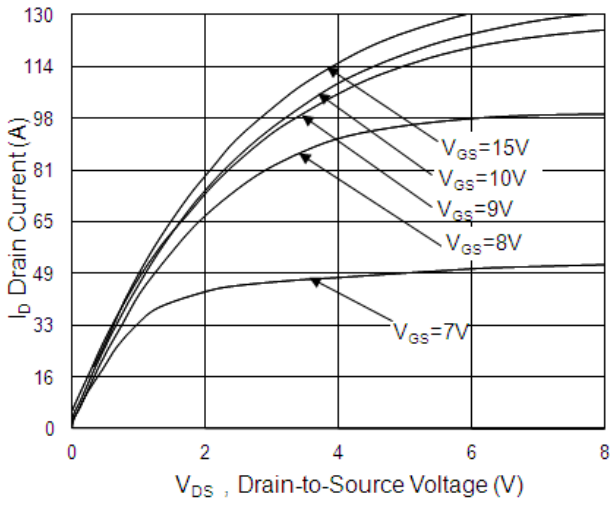
**Drain-Source Diode Characteristics**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Continuous Source Current <sup>1,5</sup>	I <sub>S</sub>	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	---	---	58	A
Pulsed Source Current <sup>2,5</sup>	I <sub>SM</sub>		---	---	130	A
Diode Forward Voltage <sup>2</sup>	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =1A, T <sub>J</sub> =25°C	---	---	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =30A, di/dt=100A/μs, T <sub>J</sub> =25°C	---	22	---	nS
Reverse Recovery Charge	Q <sub>rr</sub>		---	20	---	nC

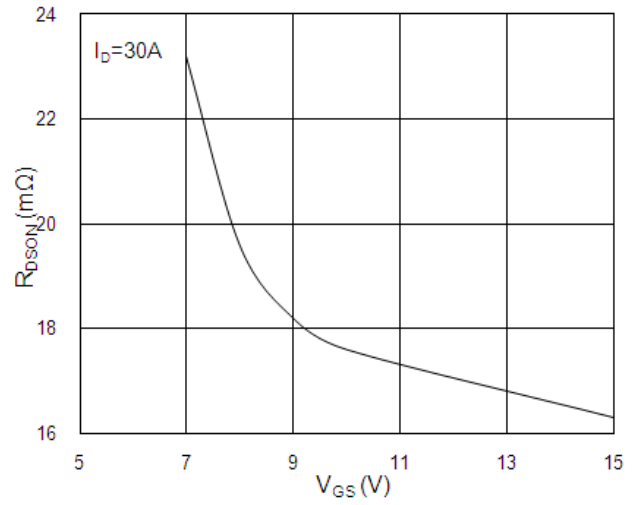
**Note:**

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%
- 3.The EAS data shows Max. rating. The test condition is V<sub>DD</sub>=25V, V<sub>GS</sub>=10V, L=0.1mH, I<sub>AS</sub>=41A
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.

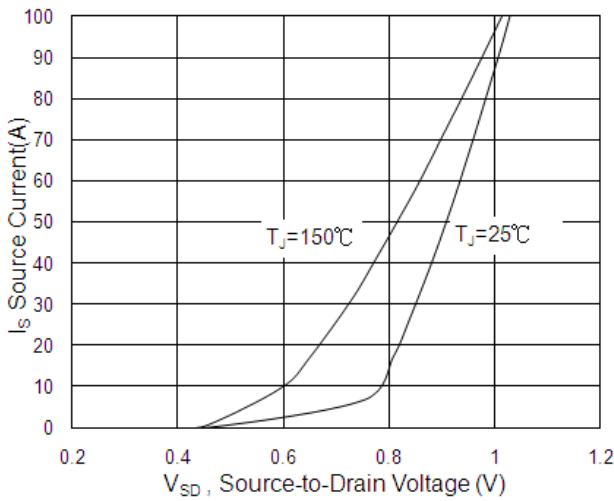
**Typical Characteristics**



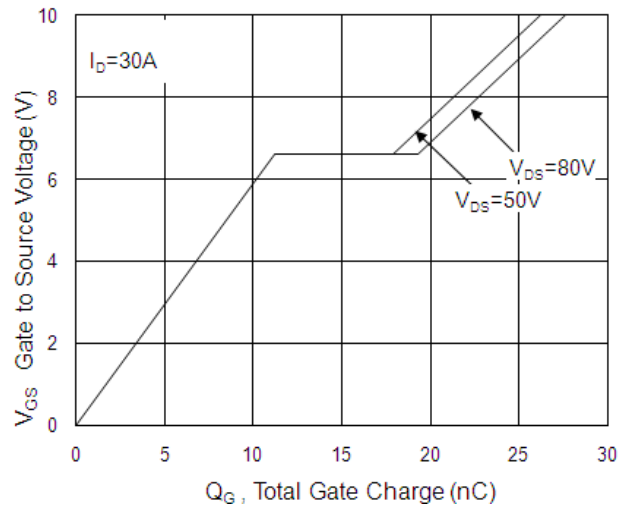
**Fig.1 Typical Output Characteristics**



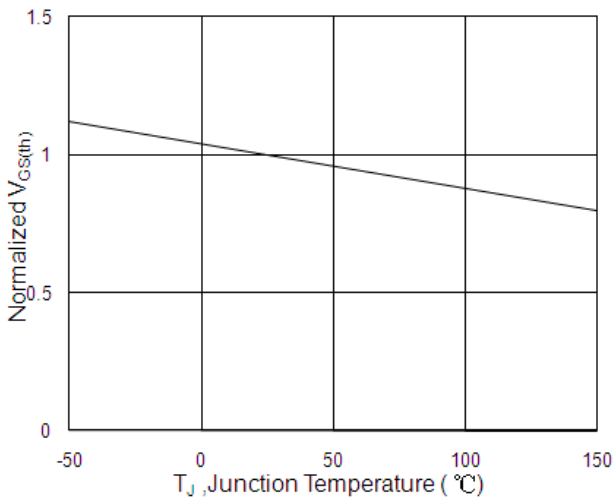
**Fig.2 On-Resistance v.s Gate-Source**



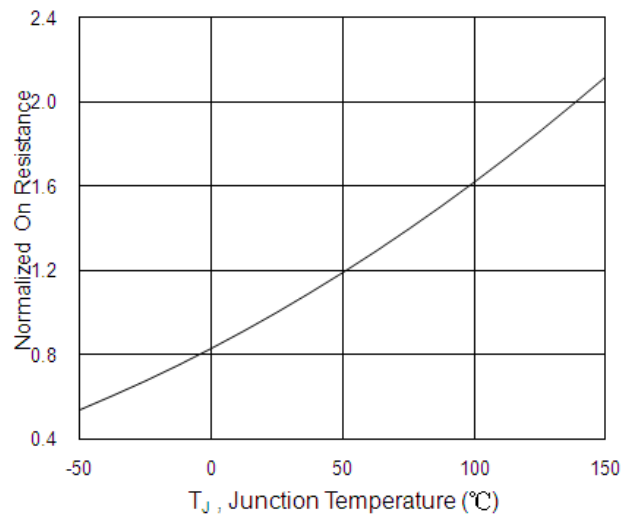
**Fig.3 Forward Characteristics of Reverse**



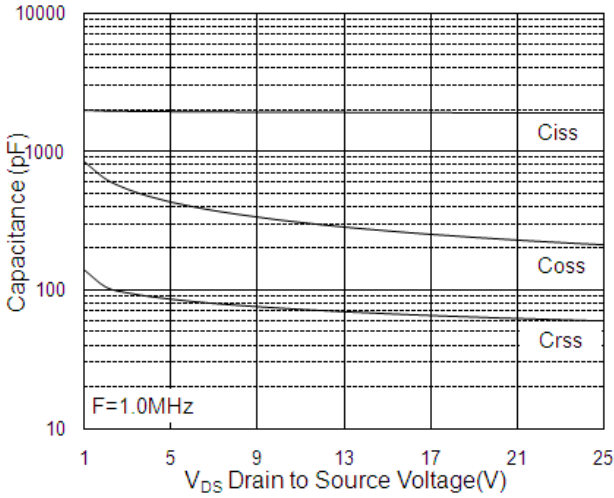
**Fig.4 Gate-Charge Characteristics**



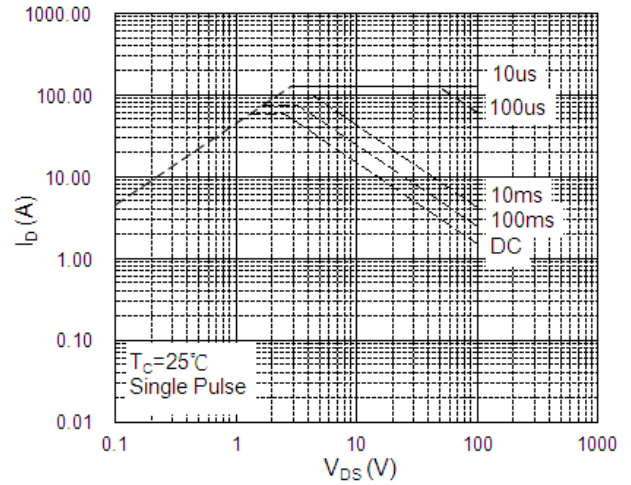
**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**



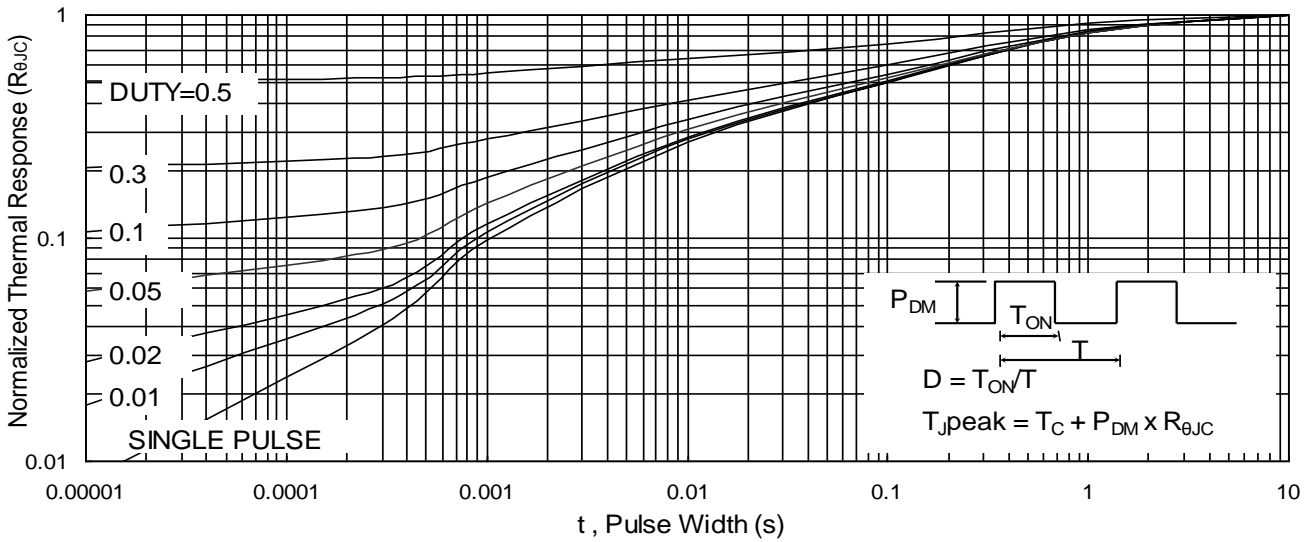
**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**



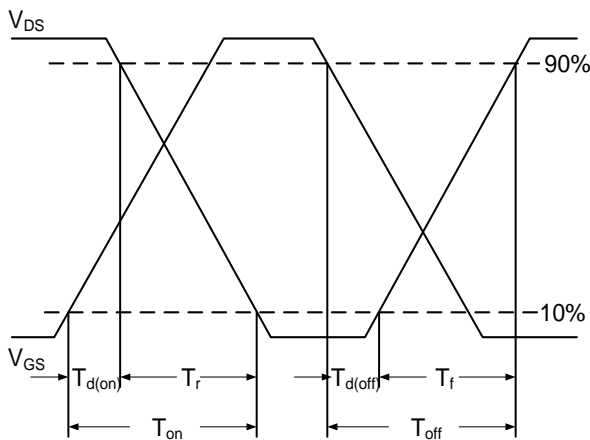
**Fig.7 Capacitance**



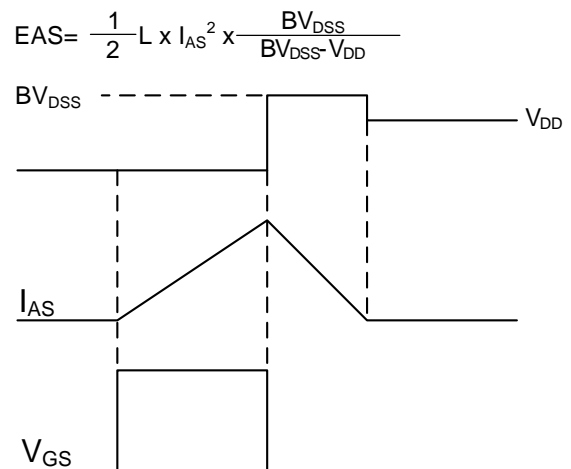
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**

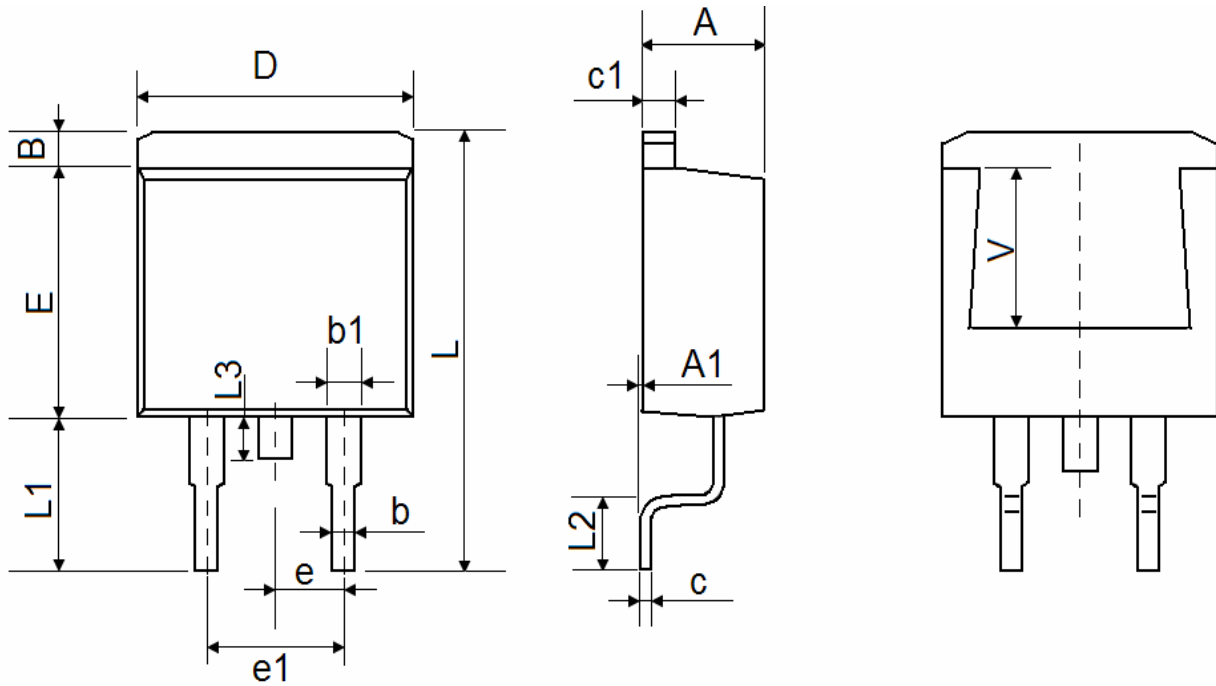


**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Waveform**

**TO-263 Package Outline Dimensions**



Symbol	Dimensions (unit:mm)			Symbol	Dimensions (unit:mm)		
	Min	Typ	Max		Min	Typ	Max
<b>A</b>	4.40	4.55	4.70	<b>A1</b>	0.00	0.07	0.15
<b>B</b>	1.00	1.20	1.40	<b>b</b>	0.65	0.80	0.95
<b>b1</b>	1.10	1.15	1.37	<b>c</b>	0.30	0.40	0.53
<b>c1</b>	1.10	1.25	1.37	<b>D</b>	9.80	10.00	10.40
<b>E</b>	8.50	8.80	9.20	<b>e</b>	2.54 REF		
<b>e1</b>	4.90	5.10	5.40	<b>L</b>	14.80	15.20	15.70
<b>L1</b>	5.00	5.25	5.60	<b>L2</b>	2.05	2.45	2.80
<b>L3</b>	1.20	1.50	1.80	<b>V</b>	5.60 REF		